Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination KOBAYASHI, HISASHI	
10/525,537		
Examiner	Art Unit	
Brian Nash	3721	

SEARCHED					
Class	Subclass	Date	Examiner		
227	131,129, 124,153, 155,5,6,7	3/13/2006	BN		
227	108,110,	3/13/2006	BN		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
227 (patents only) text, IDS, inventor search - via EAST	3/13/2006	BN	
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